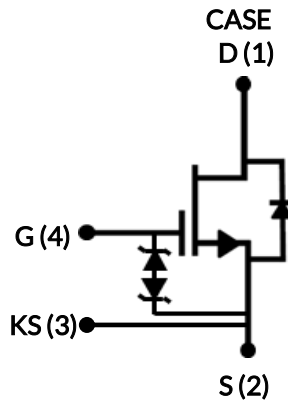


## DATASHEET

# UJ4SC075011K4S



## 750V-11mΩ SiC FET

Rev. B, July 2021

### Description

The UJ4SC075011K4S is a 750V, 11mΩ G4 SiC FET. It is based on a unique ‘cascode’ circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device’s standard gate-drive characteristics allows for a true “drop-in replacement” to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

### Features

- ◆ On-resistance  $R_{DS(on)}$ : 11mΩ (typ)
- ◆ Operating temperature: 175°C (max)
- ◆ Excellent reverse recovery:  $Q_{rr} = 288nC$
- ◆ Low body diode  $V_{FSD}$ : 1.1V
- ◆ Low gate charge:  $Q_G = 75nC$
- ◆ Threshold voltage  $V_{G(th)}$ : 4.5V (typ) allowing 0 to 15V drive
- ◆ Low intrinsic capacitance
- ◆ ESD protected, HBM class 2
- ◆ TO-247-4L package for faster switching, clean gate waveforms

Part Number	Package	Marking
UJ4SC075011K4S	TO-247-4L	UJ4SC075011K4S

### Typical applications

- ◆ EV charging
- ◆ PV inverters
- ◆ Switch mode power supplies
- ◆ Power factor correction modules
- ◆ Motor drives
- ◆ Induction heating



## Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		750	V
Gate-source voltage	$V_{GS}$	DC	-20 to +20	V
		AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>1</sup>	$I_D$	$T_C = 25^\circ\text{C}$	104	A
		$T_C = 100^\circ\text{C}$	75	A
Pulsed drain current <sup>2</sup>	$I_{DM}$	$T_C = 25^\circ\text{C}$	300	A
Single pulsed avalanche energy <sup>3</sup>	$E_{AS}$	L=15mH, $I_{AS} = 4.5\text{A}$	151	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \leq 500\text{V}$	100	V/ns
Power dissipation	$P_{tot}$	$T_C = 25^\circ\text{C}$	357	W
Maximum junction temperature	$T_{J,max}$		175	$^\circ\text{C}$
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	$^\circ\text{C}$
Max. lead temperature for soldering, 1/8" from case for 5 seconds	$T_L$		250	$^\circ\text{C}$

1. Limited by  $T_{J,max}$

2. Pulse width  $t_p$  limited by  $T_{J,max}$

3. Starting  $T_J = 25^\circ\text{C}$

4. Short circuit current is independent of the gate voltage  $V_{GS} > 12\text{V}$

## Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.33	0.42	$^\circ\text{C/W}$

## Electrical Characteristics ( $T_J = +25^\circ\text{C}$ unless otherwise specified)

### Typical Performance - Static

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Drain-source breakdown voltage	$BV_{DS}$	$V_{GS}=0V, I_D=1mA$	750			V
Total drain leakage current	$I_{DSS}$	$V_{DS}=750V,$ $V_{GS}=0V, T_J=25^\circ\text{C}$		3.5	60	$\mu\text{A}$
		$V_{DS}=750V,$ $V_{GS}=0V, T_J=175^\circ\text{C}$		45		
Total gate leakage current	$I_{GSS}$	$V_{DS}=0V, T_J=25^\circ\text{C},$ $V_{GS}=-20V / +20V$		2	$\pm 20$	$\mu\text{A}$
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=12V, I_D=60A,$ $T_J=25^\circ\text{C}$		11	14.2	m $\Omega$
		$V_{GS}=12V, I_D=60A,$ $T_J=125^\circ\text{C}$		18.4		
		$V_{GS}=12V, I_D=60A,$ $T_J=175^\circ\text{C}$		24.2		
Gate threshold voltage	$V_{G(th)}$	$V_{DS}=5V, I_D=10mA$	3.5	4.5	5.5	V
Gate resistance	$R_G$	f=1MHz, open drain		2.3		$\Omega$

### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Diode continuous forward current <sup>1</sup>	$I_S$	$T_C=25^\circ\text{C}$			104	A
Diode pulse current <sup>2</sup>	$I_{S,pulse}$	$T_C=25^\circ\text{C}$			300	A
Forward voltage	$V_{FSD}$	$V_{GS}=0V, I_F=30A,$ $T_J=25^\circ\text{C}$		1.1	1.24	V
		$V_{GS}=0V, I_F=30A,$ $T_J=175^\circ\text{C}$		1.2		
Reverse recovery charge	$Q_{rr}$	$V_R=400V, I_F=60A,$ $V_{GS}=0V, R_{G,EXT}=5\Omega$ $di/dt=2500A/\mu\text{s},$ $T_J=25^\circ\text{C}$		288		nC
Reverse recovery time	$t_{rr}$	$V_R=400V, I_F=60A,$ $V_{GS}=0V, R_{G,EXT}=5\Omega$ $di/dt=2500A/\mu\text{s},$ $T_J=25^\circ\text{C}$		26		ns
Reverse recovery charge	$Q_{rr}$	$V_R=400V, I_F=60A,$ $V_{GS}=0V, R_{G,EXT}=5\Omega$ $di/dt=2500A/\mu\text{s},$ $T_J=150^\circ\text{C}$		292		nC
Reverse recovery time	$t_{rr}$	$V_R=400V, I_F=60A,$ $V_{GS}=0V, R_{G,EXT}=5\Omega$ $di/dt=2500A/\mu\text{s},$ $T_J=150^\circ\text{C}$		26		ns

## Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Input capacitance	$C_{iss}$	$V_{DS}=400V, V_{GS}=0V$ $f=100kHz$		3245		pF
Output capacitance	$C_{oss}$			178		
Reverse transfer capacitance	$C_{rss}$			1.2		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS}=0V$ to $400V$ , $V_{GS}=0V$		225		pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS}=0V$ to $400V$ , $V_{GS}=0V$		470		pF
$C_{oss}$ stored energy	$E_{oss}$	$V_{DS}=400V, V_{GS}=0V$		18		$\mu J$
Total gate charge	$Q_G$	$V_{DS}=400V, I_D=60A$ , $V_{GS} = -0V$ to $15V$		75		nC
Gate-drain charge	$Q_{GD}$			13		
Gate-source charge	$Q_{GS}$			22		
Turn-on delay time	$t_{d(on)}$	Notes 5 and 6, $V_{DS}=400V, I_D=60A$ , Gate Driver = $0V$ to $+15V$ , Turn-on $R_{G,EXT}=1\Omega$ , Turn-off $R_{G,EXT}=5\Omega$ , inductive Load, FWD: same device with $V_{GS} = 0V$ and $R_G = 5\Omega$ , RC snubber: $R_S=10\Omega$ and $C_S=400pF$ , $T_J=25^\circ C$		19		ns
Rise time	$t_r$			26		
Turn-off delay time	$t_{d(off)}$			65		
Fall time	$t_f$			9		
Turn-on energy including $R_S$ energy	$E_{ON}$			257		
Turn-off energy including $R_S$ energy	$E_{OFF}$			107		
Total switching energy	$E_{TOTAL}$	Notes 5 and 6, $V_{DS}=400V, I_D=60A$ , Gate Driver = $0V$ to $+15V$ , Turn-on $R_{G,EXT}=1\Omega$ , Turn-off $R_{G,EXT}=5\Omega$ , inductive Load, FWD: same device with $V_{GS} = 0V$ and $R_G = 5\Omega$ , RC snubber: $R_S=10\Omega$ and $C_S=400pF$ , $T_J=150^\circ C$		364		$\mu J$
Snubber $R_S$ energy during turn-on	$E_{RS\_ON}$			8		
Snubber $R_S$ energy during turn-off	$E_{RS\_OFF}$			21		
Turn-on delay time	$t_{d(on)}$			19		
Rise time	$t_r$			28		
Turn-off delay time	$t_{d(off)}$			73		
Fall time	$t_f$	Notes 5 and 6, $V_{DS}=400V, I_D=60A$ , Gate Driver = $0V$ to $+15V$ , Turn-on $R_{G,EXT}=1\Omega$ , Turn-off $R_{G,EXT}=5\Omega$ , inductive Load, FWD: same device with $V_{GS} = 0V$ and $R_G = 5\Omega$ , RC snubber: $R_S=10\Omega$ and $C_S=400pF$ , $T_J=150^\circ C$		9		ns
Turn-on energy including $R_S$ energy	$E_{ON}$			320		
Turn-off energy including $R_S$ energy	$E_{OFF}$			125		
Total switching energy	$E_{TOTAL}$			445		
Snubber $R_S$ energy during turn-on	$E_{RS\_ON}$			8		
Snubber $R_S$ energy during turn-off	$E_{RS\_OFF}$			19		

5. Measured with the switching test circuit in Figure 29.

6. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.

### Typical Performance Diagrams

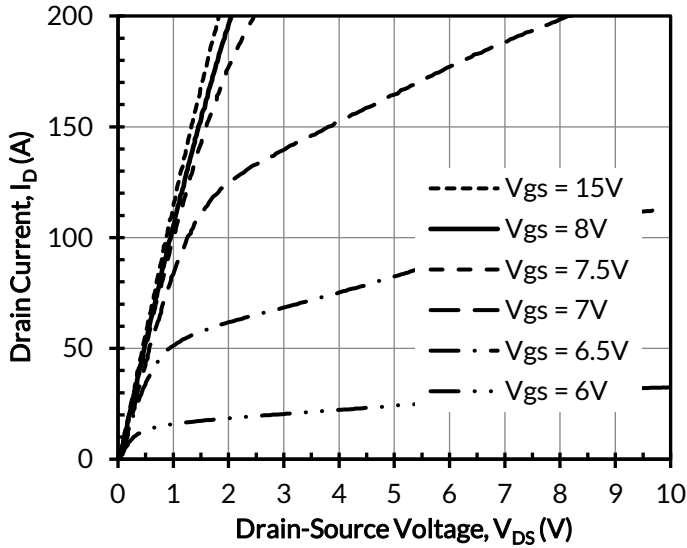


Figure 1. Typical output characteristics at  $T_j = -55^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

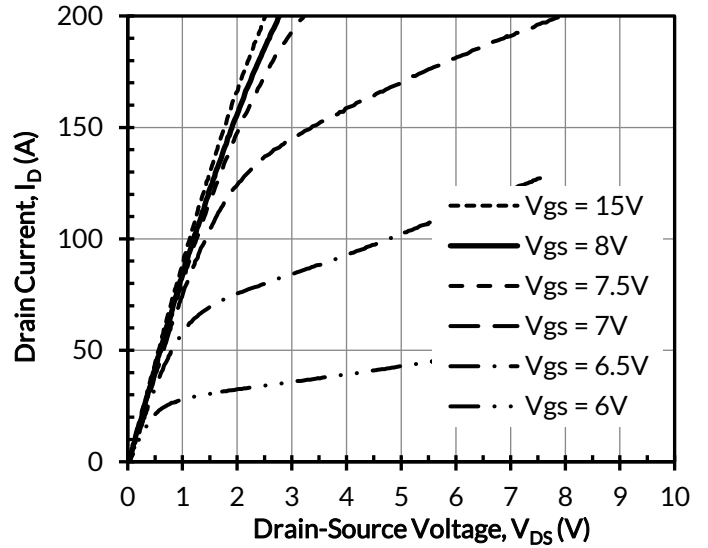


Figure 2. Typical output characteristics at  $T_j = 25^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

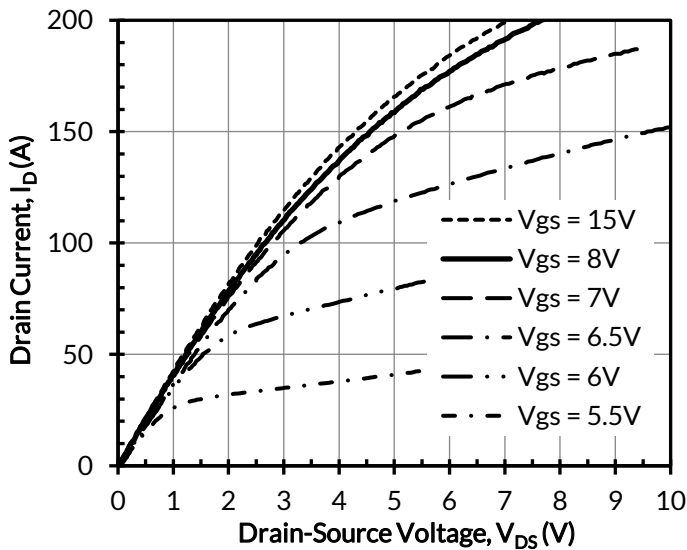


Figure 3. Typical output characteristics at  $T_j = 175^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

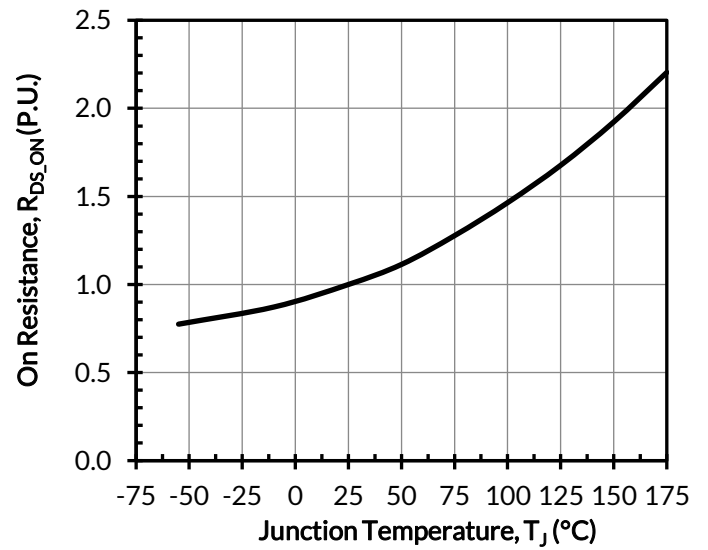


Figure 4. Normalized on-resistance vs. temperature at  $V_{GS} = 12\text{V}$  and  $I_D = 60\text{A}$

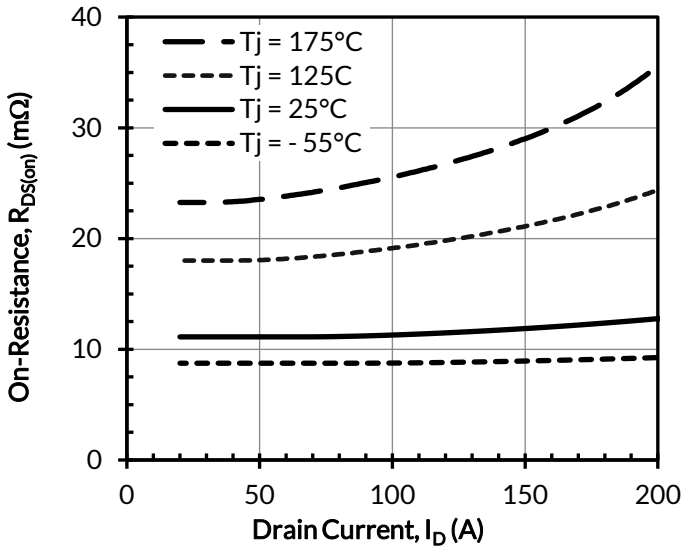


Figure 5. Typical drain-source on-resistances at  $V_{GS} = 12V$

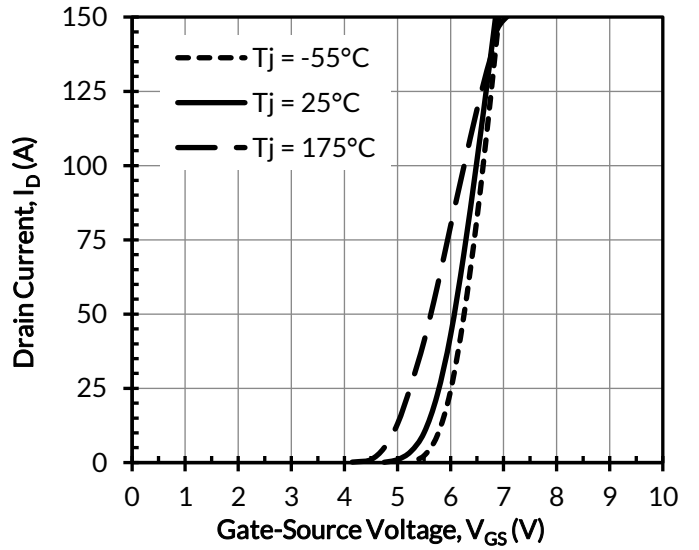


Figure 6. Typical transfer characteristics at  $V_{DS} = 5V$

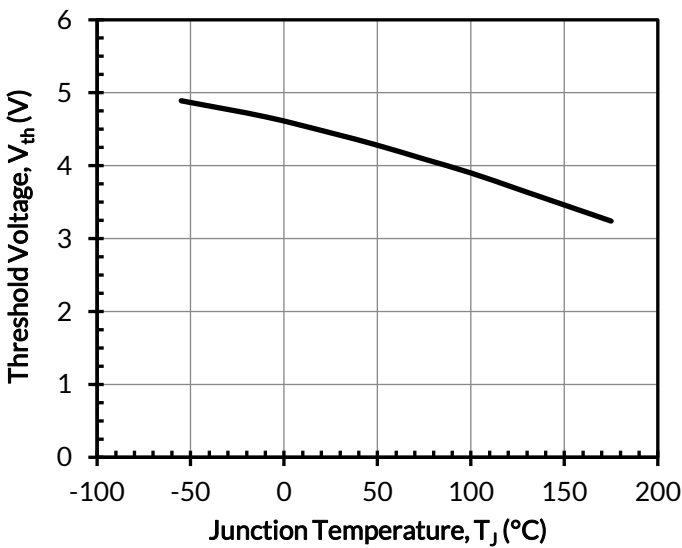


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS} = 5V$  and  $I_D = 10mA$

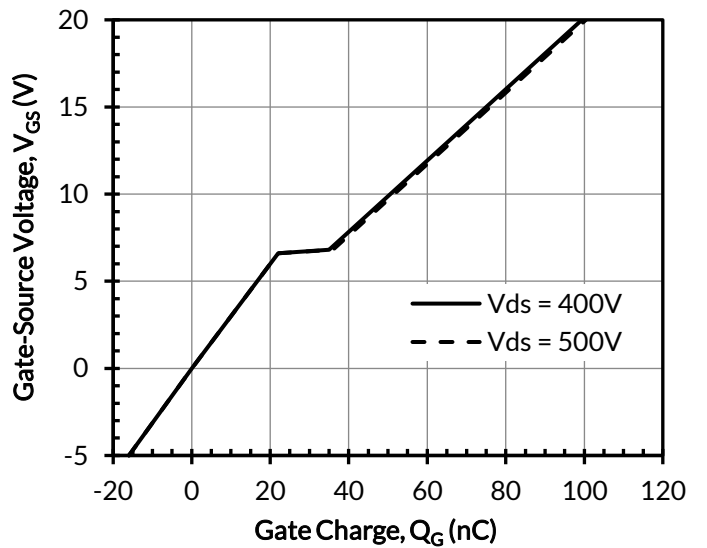


Figure 8. Typical gate charge at  $I_D = 60A$

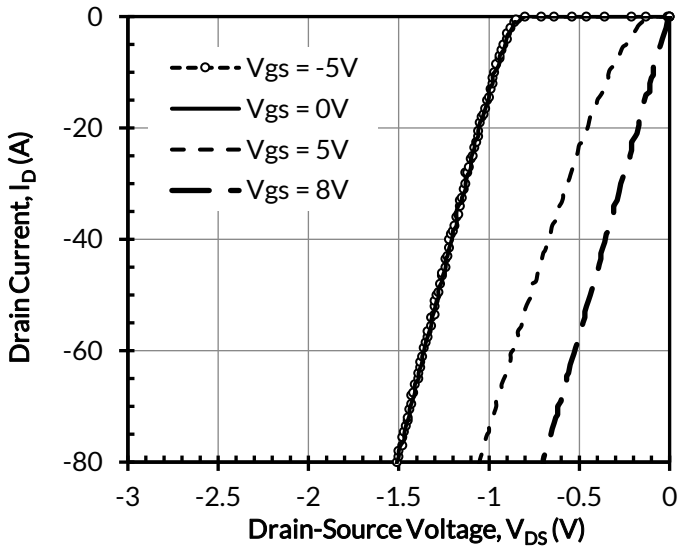


Figure 9. 3rd quadrant characteristics at  $T_j = -55^\circ\text{C}$

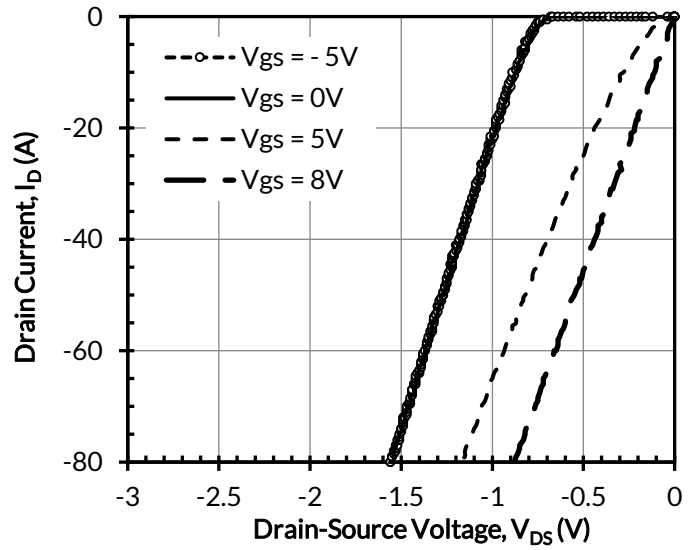


Figure 10. 3rd quadrant characteristics at  $T_j = 25^\circ\text{C}$

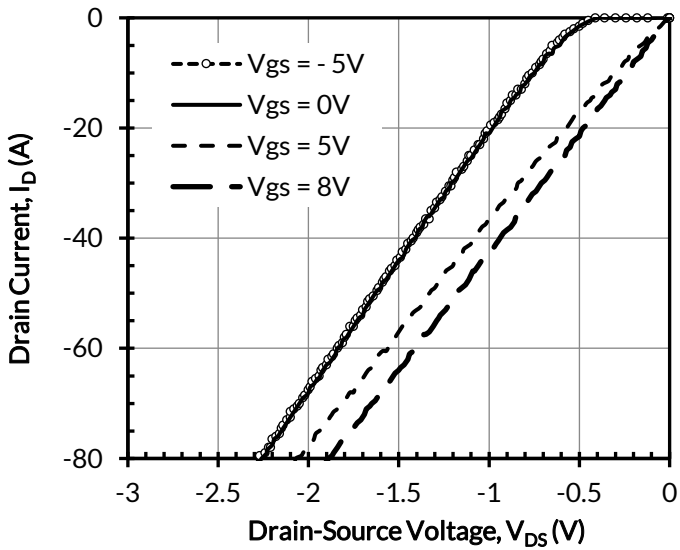


Figure 11. 3rd quadrant characteristics at  $T_j = 175^\circ\text{C}$

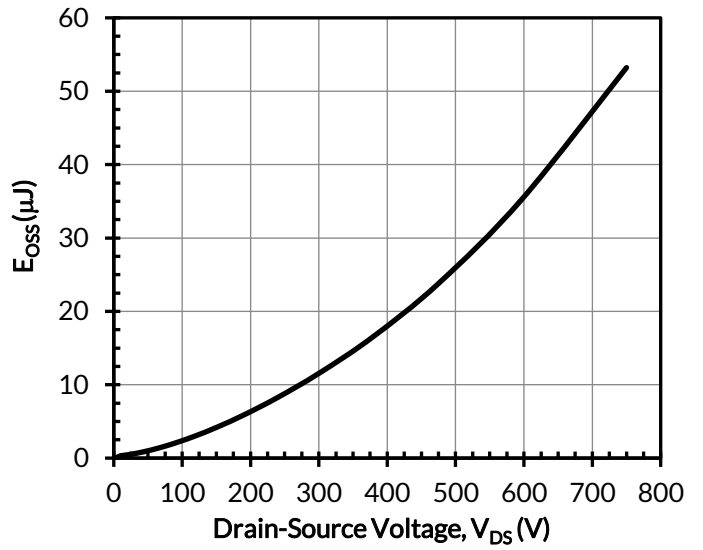


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0\text{V}$

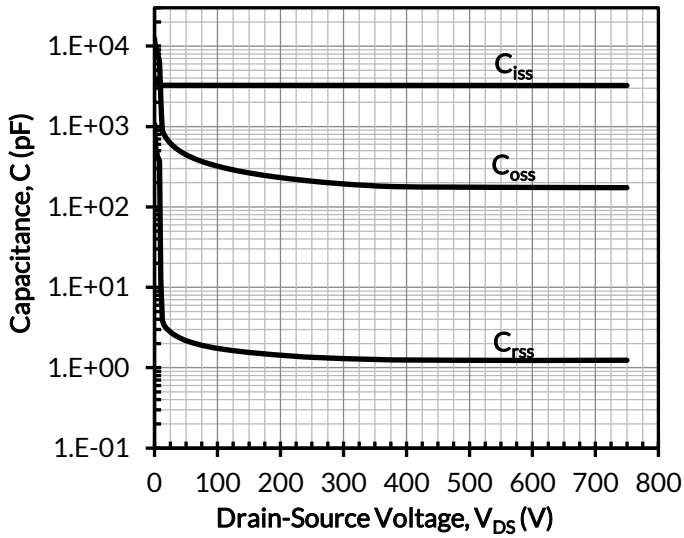


Figure 13. Typical capacitances at  $f = 100\text{kHz}$  and  $V_{GS} = 0\text{V}$

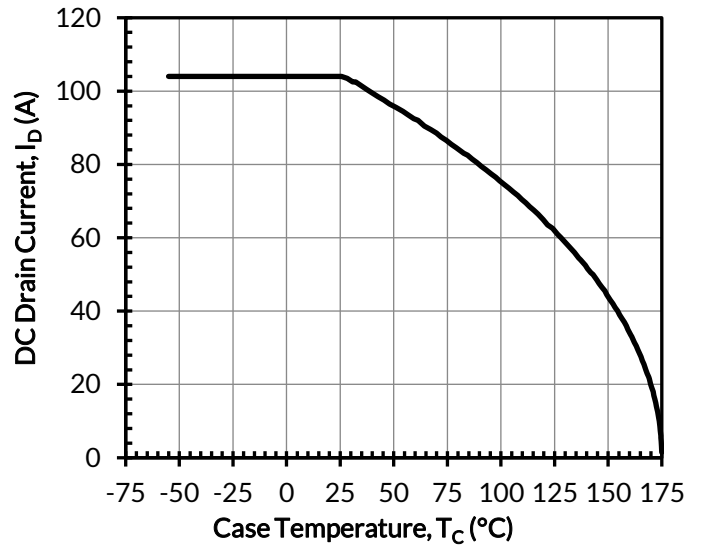


Figure 14. DC drain current derating

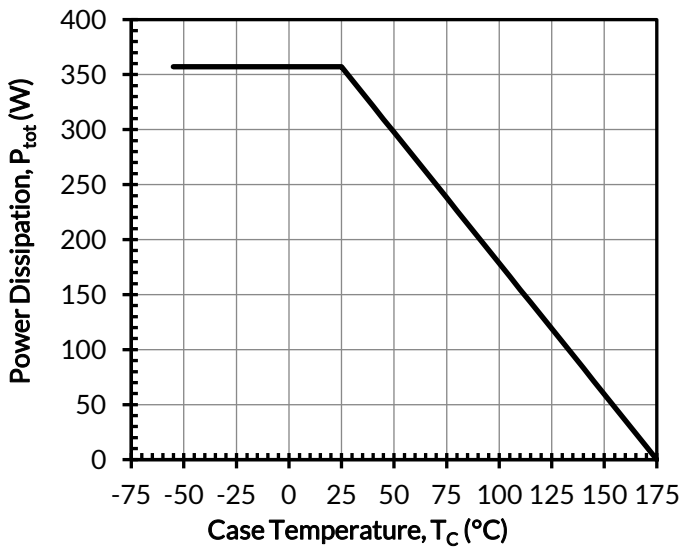


Figure 15. Total power dissipation

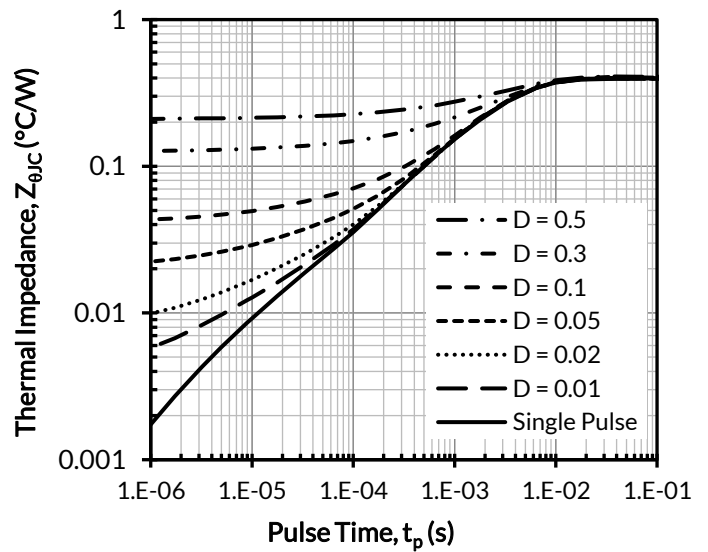


Figure 16. Maximum transient thermal impedance



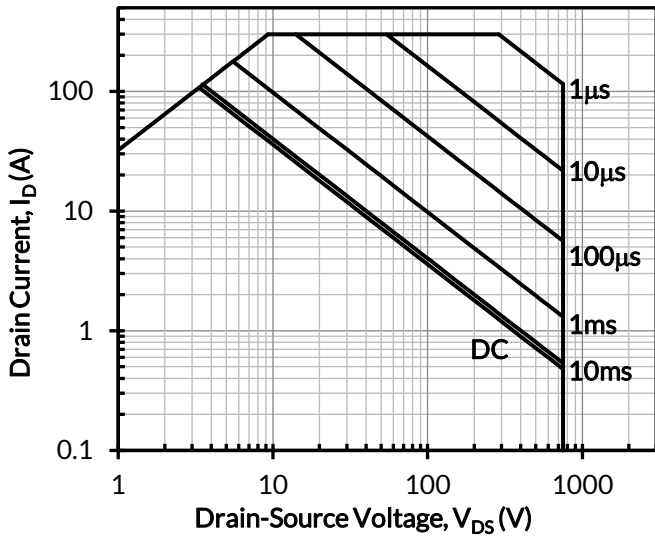


Figure 17. Safe operation area at  $T_C = 25^\circ\text{C}$ ,  $D = 0$ , Parameter  $t_p$

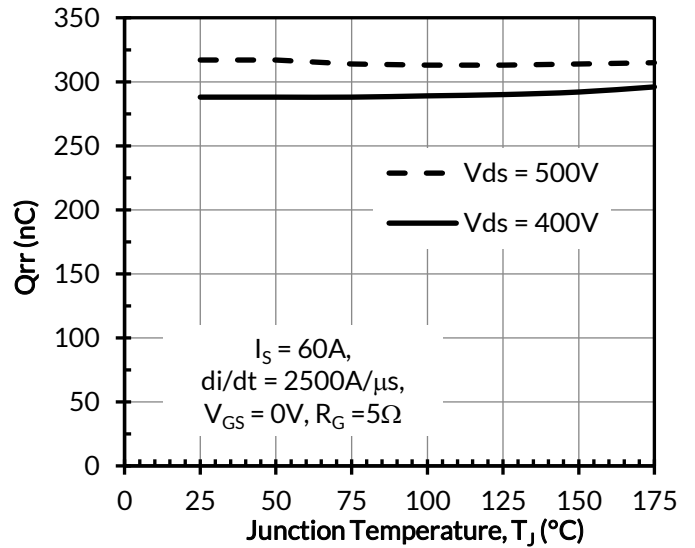


Figure 18. Reverse recovery charge  $Q_{rr}$  vs. junction temperature

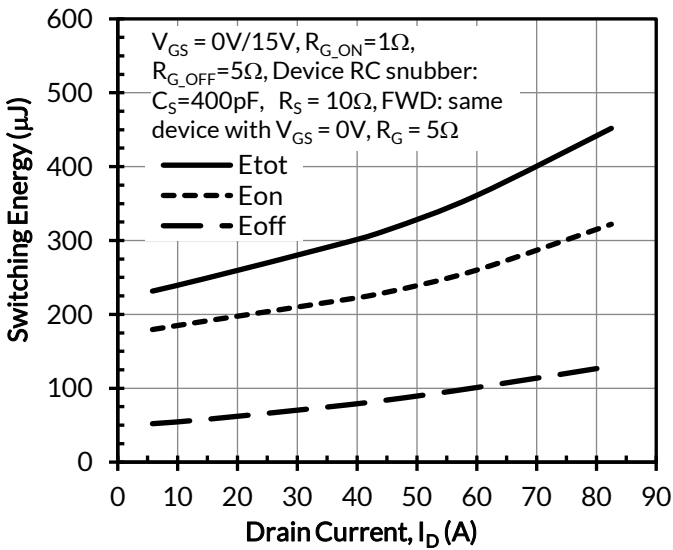


Figure 19. Clamped inductive switching energy vs. drain current at  $V_{DS} = 400\text{V}$  and  $T_J = 25^\circ\text{C}$

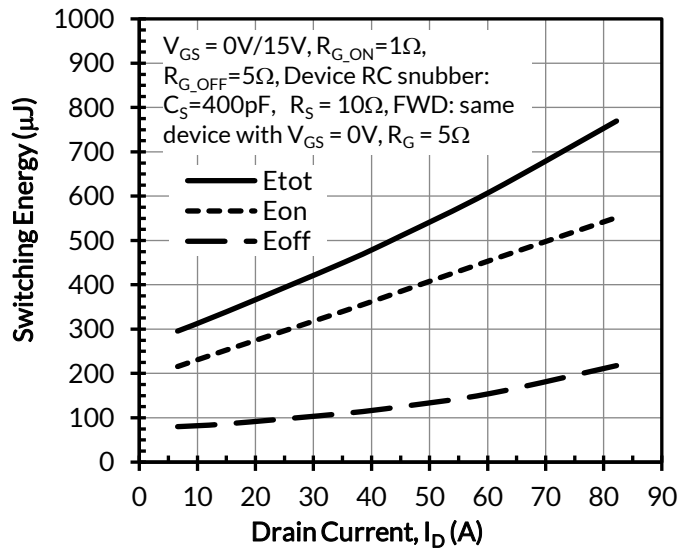


Figure 20. Clamped inductive switching energy vs. drain current at  $V_{DS} = 500\text{V}$  and  $T_J = 25^\circ\text{C}$

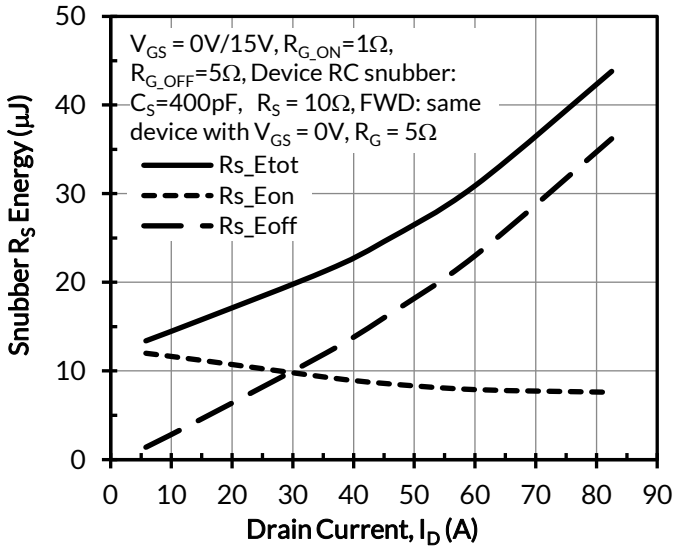


Figure 21. RC snubber energy loss vs. drain current at  $V_{DS} = 400V$  and  $T_J = 25^\circ C$

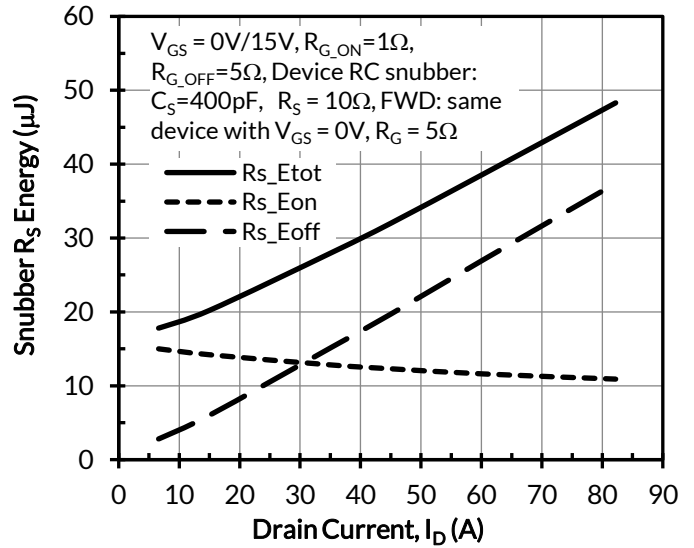


Figure 22. RC snubber energy losses vs. drain current at  $V_{DS} = 500V$  and  $T_J = 25^\circ C$

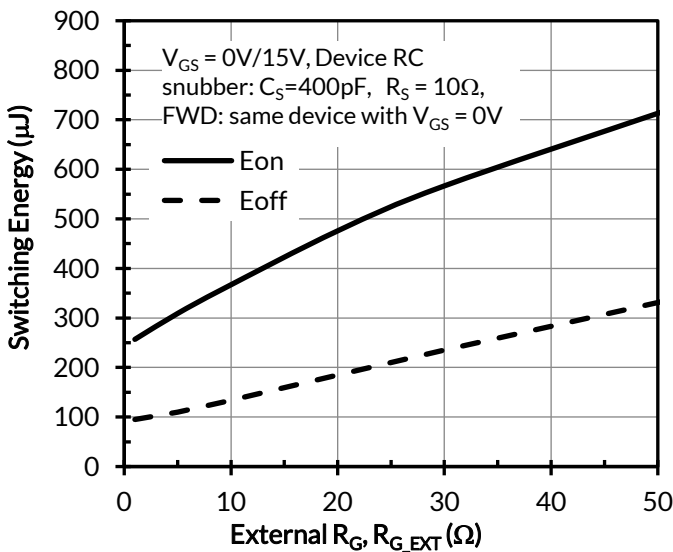


Figure 23. Clamped inductive switching energies vs.  $R_{G,EXT}$  at  $V_{DS} = 400V, I_D = 60A,$  and  $T_J = 25^\circ C$

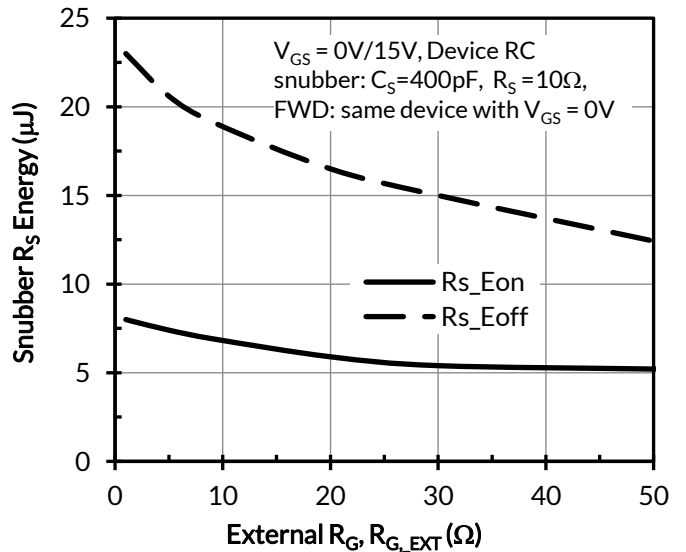


Figure 24. RC snubber energy losses vs.  $R_{G,EXT}$  at  $V_{DS} = 400V, I_D = 60A,$  and  $T_J = 25^\circ C$

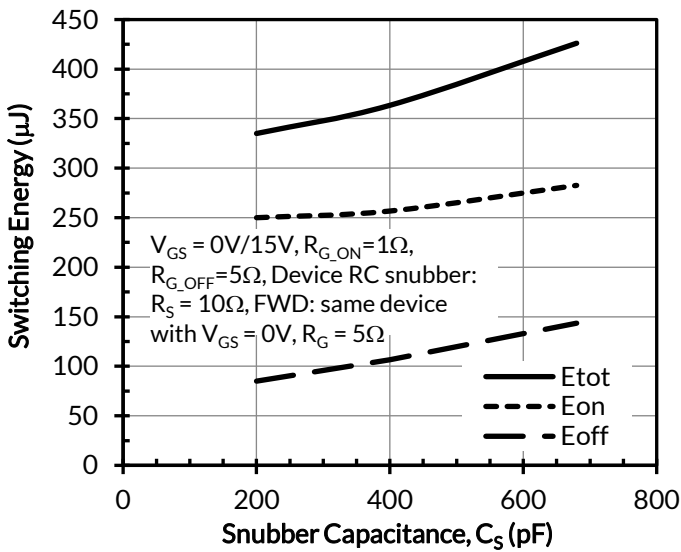


Figure 25. Clamped inductive switching energies vs. snubber capacitance  $C_S$  at  $V_{DS} = 400V$ ,  $I_D = 60A$ , and  $T_J = 25^\circ C$

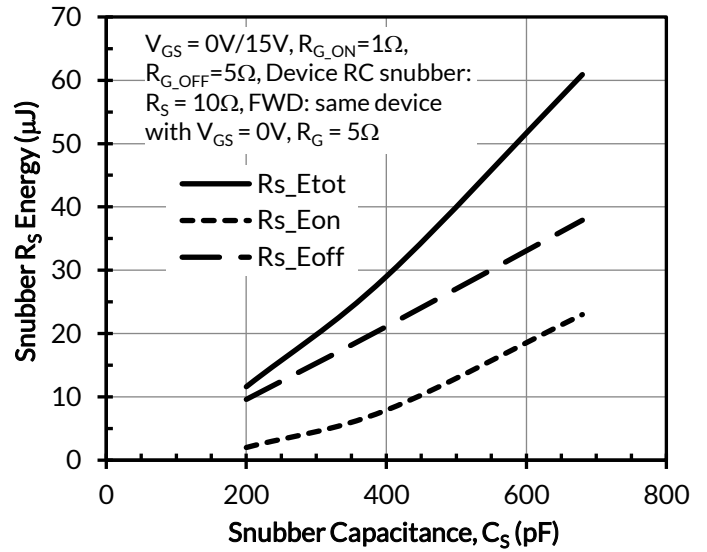


Figure 26. RC snubber energy losses vs. snubber capacitance  $C_S$  at  $V_{DS} = 400V$ ,  $I_D = 60A$ , and  $T_J = 25^\circ C$

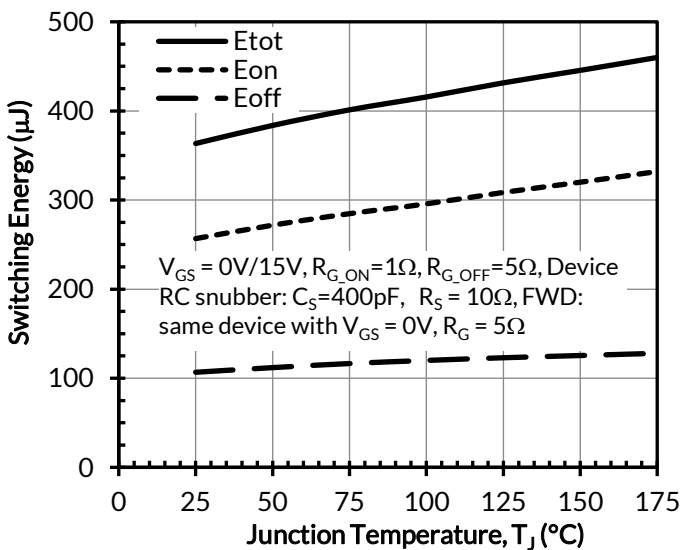


Figure 27. Clamped inductive switching energy vs. junction temperature at  $V_{DS} = 400V$  and  $I_D = 60A$

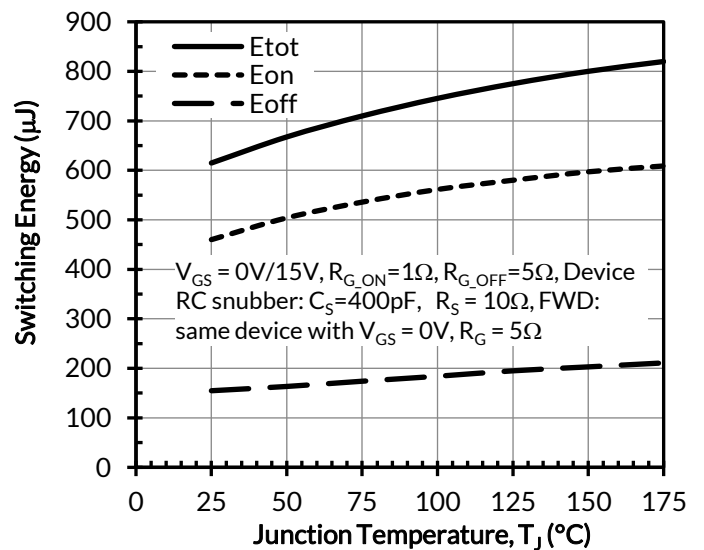


Figure 28. Clamped inductive switching energy vs. junction temperature at  $V_{DS} = 500V$  and  $I_D = 60A$

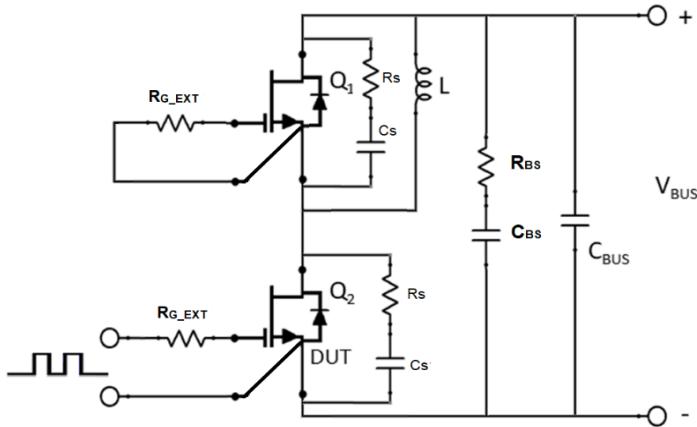


Figure 29. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ( $R_{BS} = 1\Omega$ ,  $C_{BS} = 100\text{nF}$ ) is used to reduce the power loop high frequency oscillations.

## Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high  $dv/dt$  and  $di/dt$  rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see [www.unitedsic.com](http://www.unitedsic.com).

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